Search Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination
09/843,358	CHEN ET AL.
Examiner	Art Unit
Nhan T. Le	2685

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
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